

Automotive-grade N-channel 400 V, 0.063 Ω typ., 38 A MDmesh[™] DM2 Power MOSFET in a TO-220 package

Datasheet - production data

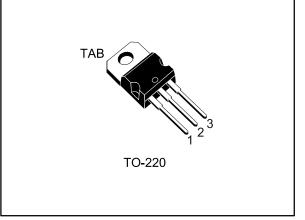
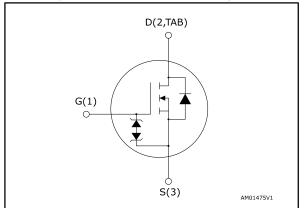


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ID	Ртот
STP45N40DM2AG	400 V	0.072 Ω	38 A	250 W

- Designed for automotive applications and AEC-Q101 qualified
- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmesh[™] DM2 fast recovery diode series. It offers very low recovery charge (Qrr) and time (trr) combined with low R_{DS(on)}, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summar

Order code	Marking	Package	Packing
STP45N40DM2AG	45N40DM2	TO-220	Tube

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This is information on a product in full production.

Contents

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vgs	Gate-source voltage	±25	V
la la	Drain current (continuous) at T _{case} = 25 °C	38	А
lo	Drain current (continuous) at T _{case} = 100 °C	24	A
IDM ⁽¹⁾	Drain current (pulsed)	152	А
Ртот	Total dissipation at T _{case} = 25 °C	250	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	50	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	v/ns
T _{stg}	Storage temperature range	55 to 150	°C
Tj	Operating junction temperature range	-55 to 150	C

Notes:

 $^{\left(1\right) }$ Pulse width is limited by safe operating area.

 $^{(2)}$ I_{SD} \leq 38 A, di/dt=800 A/µs; V_{DS} peak < V_(BR)DSS,V_{DD} = 80% V(BR)DSS.

 $^{(3)}$ V_{DS} \leq 320 V

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj} -case	Thermal resistance junction-case	0.5	°C / M
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter		Unit
I _{AR}	Avalanche current, repetitive or not repetitive	7	А
Eas ⁽¹⁾	Single pulse avalanche energy	1100	mJ

Notes:

 $^{(1)}$ starting T_{j} = 25 °C, I_{D} = IAR, V_{DD} = 50 V.



2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 1 mA$	400			V
	$I_{DSS} \begin{array}{c} \text{Zero gate voltage drain} \\ \text{current} \end{array} \begin{array}{c} V_{GS} = 0 \text{ V}, V_{DS} = 400 \text{ V} \\ \hline V_{GS} = 0 \text{ V}, V_{DS} = 400 \text{ V}, \\ T_{case} = 125 ^{\circ}\text{C}^{(1)} \end{array}$			10		
IDSS					100	μA
Igss	Gate-body leakage current	$V_{DS} = 0 V$, $V_{GS} = \pm 25 V$			±5	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 19 A		0.063	0.072	Ω

Notes:

⁽¹⁾Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	2600	-	
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, \text{ f} = 1 \text{ MHz}, \\ V_{GS} = 0 \text{ V}$	-	180	-	рF
C _{rss}	Reverse transfer capacitance		-	3.5	-	יב
Coss eq. ⁽¹⁾	Equivalent output capacitance	V_{DS} = 0 to 320 V, V_{GS} = 0 V	-	300	-	рF
Rg	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	-	4	-	Ω
Qg	Total gate charge	$V_{DD} = 320 \text{ V}, \text{ I}_{D} = 38 \text{ A},$	-	56	-	
Qgs	Gate-source charge	V _{GS} = 10 V (see Figure 15: "Test circuit for gate charge	-	13	-	nC
Q _{gd}	Gate-drain charge	behavior")	-	28	-	

Table 6: Dynamic

Notes:

 $^{(1)}$ $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 200 \text{ V}, I_D = 19 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 14: "Test circuit for</i>	-	20	-	
tr	Rise time		-	6.7	-	
td(off)	Turn-off delay time		-	68	-	ns
tr	Fall time	resistive load switching times")	-	9.8	-	

Table 7: Switching times



Electrical characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isd	Source-drain current		-		38	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		152	А
Vsd ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 38 A	-		1.6	V
trr	Reverse recovery time	I _{SD} = 38 A, di/dt = 100 A/μs, V _{DD} = 60 V (see <i>Figure 16:</i> " <i>Test circuit for inductive load</i> <i>switching and diode recovery</i> <i>times</i> ")	-	95		ns
Qrr	Reverse recovery charge		-	0.4		μC
I _{RRM}	Reverse recovery current		-	8.5		А
trr	Reverse recovery time	I _{SD} = 38 A, di/dt = 100 A/µs,	-	185		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{\text{j}} = 150 \text{ °C}$ (see Figure 16: "Test circuit for	-	1.62		μC
Irrm	Reverse recovery current	inductive load switching and diode recovery times")	-	17.5		А

Notes:

 $^{\left(1\right) }$ Pulse width is limited by safe operating area.

 $^{(2)}$ Pulse test: pulse duration = 300 $\mu s,$ duty cycle 1.5%.

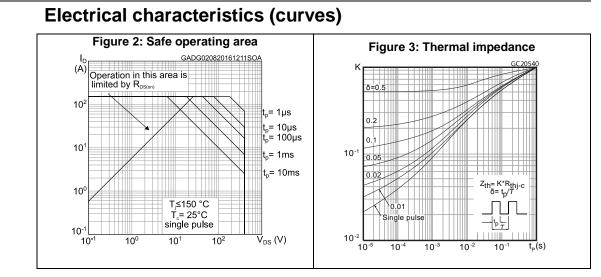
Table 9: Gate-source Zener diode

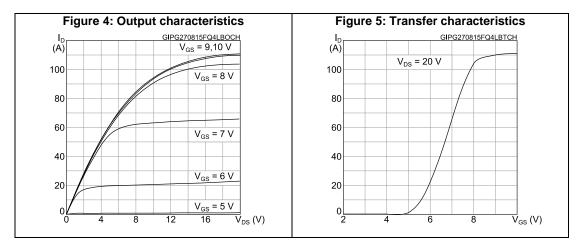
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS} = \pm 250 \ \mu A, I_D = 0 \ A$	±30	-	-	V

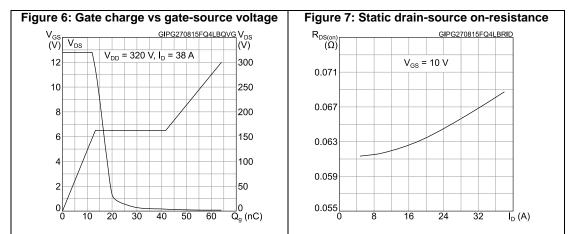
The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



2.1



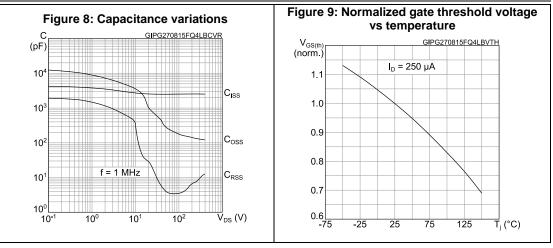


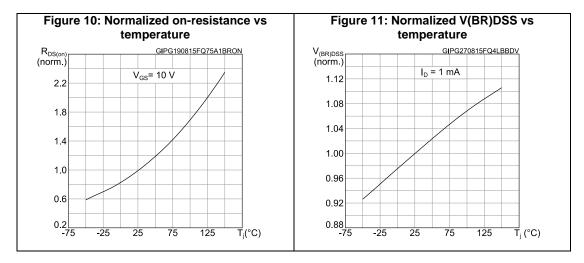


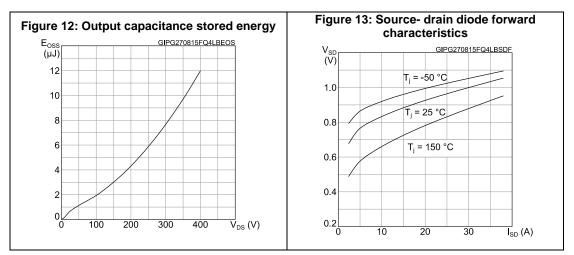
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Electrical characteristics



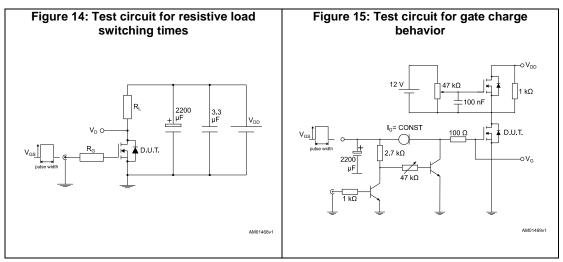


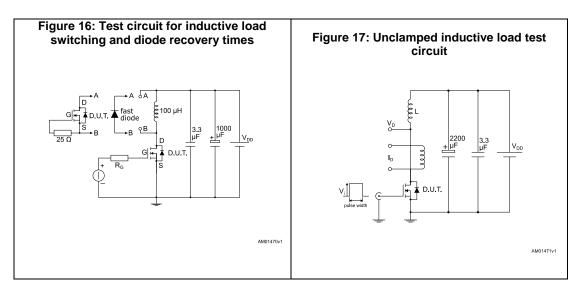


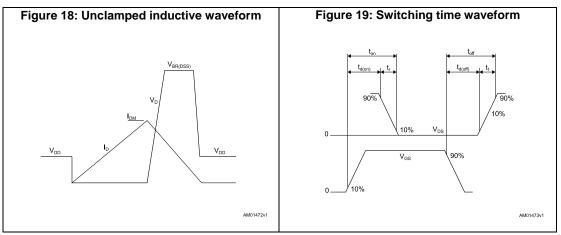
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3 Test circuits







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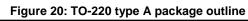


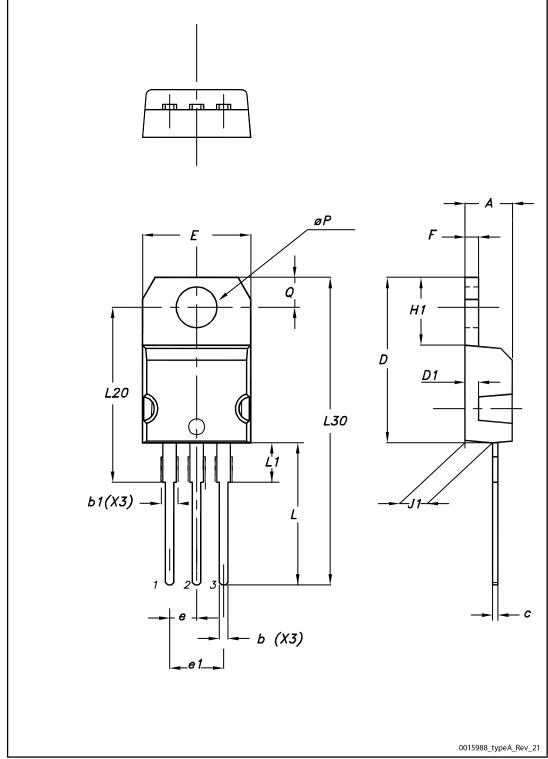
4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.











Package information

DMZAG			Package information	
Table 10: TO-220 type A mechanical data				
Dim.	mm			
	Min.	Тур.	Max.	
A	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.55	
С	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10.00		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13.00		14.00	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
øP	3.75		3.85	
Q	2.65		2.95	



Revision history 5

Table 11:	Document	revision	history
	Document	10131011	III SLOI y

Date	Revision	Changes	
06-Jul-2015	1	First release.	
03-Sep-2015	2	Datasheet promoted from preliminary data to production data Modified: I _D , I _{DM} , dv/dt values in table 2 Added: note 2 and 3 in table2 Modified: the entire values in table 4 Modified: R _{DS(on)} typical value in table 5 Modified: the entire typical values in table 6 and 7 Modified: the entire typical values and I _{SD} , I _{SDM} in table 8 Added: Electrical characteristics (curves) section Minor text changes	
02-Aug-2016	3	Modified title in cover page. Updated Section 1: "Electrical ratings", Table 5: "Static", Table 8: "Source-drain diode" and Figure 2: "Safe operating area". Minor text changes.	



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